

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,092	TAKE, KEIJIRO	
Examiner	Art Unit	
Tri H. Phan	2661	

SEARCHED					
Class	Subclass	Date	Examiner		
370	320,335, 342,441, 479,203	11/30/2004	TP		
370	350,332	11/30/2004	ТР		
370	508-510	11/30/2004	TP		
375	200	11/30/2004	TP		
Updated	search	6/17/2005	TP		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE, Internet searched	11/30/2004	TP .		
Consulted with Sam Phirin (Pri)	4/7/2005	TP.		
Updated search	6/17/2005	TP		
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